

Title (en)

ADAPTER SYSTEM FOR COMPONENT BOARDS, FOR USE IN A TEST DEVICE

Title (de)

ADAPTERSYSTEM FÜR BAUGRUPPEN-PLATINEN, ZU VERWENDEN IN EINER PRÜFEINRICHTUNG

Title (fr)

SYSTEME ADAPTATEUR POUR PLAQUETTES A COMPOSANTS, DESTINE A ETRE UTILISE DANS UN DISPOSITIF D'ESSAI

Publication

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Application

EP 96906726 A 19960301

Priority

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Abstract (en)

[origin: DE19507127A1] The invention concerns a test device for component boards (31). The test device in question comprises a plurality of test channels which are contact-connected by spring contact pins (2, 3) to the relevant test sites (32) on the board (31). According to the invention, a grid plate (21) is provided to ensure contact between the spring contact pins and the contacts (29) of the test channels and is provided with contact faces (22) on the face in contact with the spring contact pins; a number n of the said contact faces are connected electrically in parallel with a test channel, and the contact faces (no. 1, no. 2,... no. 21,... no. 41,...) of the test channels (a1, a2,... b1,... c1,...) are intermixed and distributed over the surface of the grid plate.

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